

Notice of References Cited	Application/Control No. 10/053,085	Applicant(s)/Patent Under Reexamination GORTE ET-AL.	
	Examiner Dah-Wei D. Yuan	Art-Unit 1745	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,017,647	01-2000	Wallin, Sten A.	429/33
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	L	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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